

FEATURES

6.5 Ω (maximum) on resistance 0.8 Ω (maximum) on-resistance flatness 2.7 V to 5.5 V single supply ±2.7 V to ±5.5 V dual supply Rail-to-rail operation 8-lead SOT-23, 8-lead MSOP Typical power consumption (<0.1 μW) TTL-/CMOS-compatible inputs

APPLICATIONS

Automatic test equipment Power routing Communication systems Data acquisition systems Sample-and-hold systems Avionics Relay replacement Battery-powered systems

GENERAL DESCRIPTION

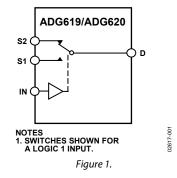
The ADG619/ADG620 are monolithic, CMOS single-pole double-throw (SPDT) switches. Each switch conducts equally well in both directions when the device is on.

The ADG619/ADG620 offer a low on resistance of 4 Ω , which is matched to within 0.7 Ω between channels. These switches also provide low power dissipation, yet result in high switching speeds. The ADG619 exhibits break-before-make switching action, thus preventing momentary shorting when switching channels. The ADG620 exhibits make-before-break action.

The ADG619/ADG620 are available in an 8-lead SOT-23 and an 8-lead MSOP.

CMOS, ±5 V/+5 V, 4 Ω, Single SPDT Switches ADG619/ADG620

FUNCTIONAL BLOCK DIAGRAM



PRODUCT HIGHLIGHTS

- 1. Low on resistance (R_{ON}): 4 Ω typical.
- 2. Dual ± 2.7 V to ± 5.5 V or single 2.7 V to 5.5 V supplies.
- 3. Low power dissipation.
- 4. Fast t_{ON}/t_{OFF} .
- 5. Tiny, 8-lead SOT-23 and 8-lead MSOP.

Table 1. Truth Table for the ADG619/ADG620

| IN | Switch S1 | Switch S2 |
|----|-----------|-----------|
| 0 | On | Off |
| 1 | Off | On |

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REVISION HISTORY

| 3/07—Rev. B to Rev. C | |
|----------------------------------|----|
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6/03—Rev. 0 to Rev. A.

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SPECIFICATIONS

DUAL SUPPLY

 V_{DD} = +5 V ± 10%, V_{SS} = -5 V ± 10%, GND = 0 V. All specifications -40°C to +85°C, unless otherwise noted.

Table 2.

| | B Version ¹ | | | | |
|--|------------------------|----------------|---------|--|--|
| Parameter | +25°C | -40°C to +85°C | Unit | Test Conditions/Comments | |
| ANALOG SWITCH | | | | | |
| Analog Signal Range | | Vss to VDD | V | $V_{DD} = +4.5 \text{ V}, \text{V}_{SS} = -4.5 \text{ V}$ | |
| On Resistance (R _{ON}) | 4 | | Ωtyp | $V_{s} = \pm 4.5 V$, $I_{Ds} = -10 mA$; see Figure 15 | |
| | 6.5 | 8.5 | Ωmax | | |
| R_{ON} Match Between Channels (ΔR_{ON}) | 0.7 | | Ωtyp | $V_{s} = \pm 4.5 V$, $I_{Ds} = -10 mA$ | |
| | 1.1 | 1.35 | Ωmax | | |
| On-Resistance Flatness (R _{FLAT (ON)}) | 0.7 | 0.8 | Ωtyp | $V_{s} = \pm 3.3 \text{ V}, I_{Ds} = -10 \text{ mA}$ | |
| | 1.35 | 1.4 | Ωmax | | |
| LEAKAGE CURRENTS | | | | $V_{DD} = +5.5 V, V_{SS} = -5.5 V$ | |
| Source Off Leakage, Is (Off) | ±0.01 | | nA typ | $V_s = \pm 4.5 V$, $V_D = \mp 4.5 V$; see Figure 16 | |
| | ±0.25 | ±1 | nA max | | |
| Channel On Leakage, I _D , I _s (On) | ±0.01 | | nA typ | $V_s = V_D = \pm 4.5 V$; see Figure 17 | |
| | ±0.25 | ±1 | nA max | | |
| DIGITAL INPUTS | | | | | |
| Input High Voltage, VINH | | 2.4 | V min | | |
| Input Low Voltage, V _{INL} | | 0.8 | V max | | |
| Input Current, I _{INL} or I _{INH} | 0.005 | | μA typ | $V_{IN} = V_{INL} \text{ or } V_{INH}$ | |
| | | ±0.1 | µA max | | |
| Digital Input Capacitance, C _{IN} | 2 | | pF typ | | |
| DYNAMIC CHARACTERISTICS ² | | | | | |
| ADG619 | | | | | |
| t _{on} | 80 | | ns typ | $R_L = 300 \Omega, C_L = 35 pF$ | |
| | 120 | 155 | ns max | $V_s = 3.3 V$; see Figure 18 | |
| toff | 45 | | ns typ | $R_L = 300 \Omega, C_L = 35 pF$ | |
| | 75 | 90 | ns max | Vs = 3.3 V; see Figure 18 | |
| Break-Before-Make Time Delay, t _{BBM} | 40 | | ns typ | $R_L = 300 \Omega$, $C_L = 35 pF$ | |
| | | 10 | ns min | $V_{S1} = V_{S2} = 3.3 V$; see Figure 19 | |
| ADG620 | | | | | |
| ton | 40 | | ns typ | $R_L = 300 \Omega$, $C_L = 35 pF$ | |
| | 65 | 85 | ns max | $V_s = 3.3 V$; see Figure 18 | |
| toff | 200 | | ns typ | $R_L = 300 \Omega$, $C_L = 35 pF$ | |
| | 330 | 400 | ns max | $V_s = 3.3 V$; see Figure 18 | |
| Make-Before-Break Time Delay, t _{MBB} | 160 | | ns typ | $R_L = 300 \Omega$, $C_L = 35 pF$ | |
| | | 10 | ns min | $V_s = 0 V$; see Figure 20 | |
| Charge Injection | 110 | | pC typ | $V_s = 0 V$, $R_s = 0 \Omega$, $C_L = 1 nF$; see Figure 21 | |
| Off Isolation | -67 | | dB typ | $R_L = 50 \Omega$, $C_L = 5 pF$, $f = 1 MHz$; see Figure 22 | |
| Channel-to-Channel Crosstalk | -67 | | dB typ | $R_L = 50 \Omega$, $C_L = 5 pF$, $f = 1 MHz$; see Figure 23 | |
| Bandwidth –3 dB | 190 | | MHz typ | $R_L = 50 \Omega$, $C_L = 5 pF$; see Figure 24 | |
| Cs (Off) | 25 | | pF typ | f = 1 MHz | |
| C _D , C _S (On) | 95 | | pF typ | f = 1 MHz | |

| | B Version ¹ | | | | |
|--------------------|------------------------|----------------|--------|--|--|
| Parameter | +25°C | -40°C to +85°C | Unit | Test Conditions/Comments | |
| POWER REQUIREMENTS | | | | $V_{DD} = +5.5 V, V_{SS} = -5.5 V$ | |
| I _{DD} | 0.001 | | μA typ | Digital inputs = $0 V \text{ or } 5.5 V$ | |
| | | 1.0 | µA max | | |
| I _{SS} | 0.001 | | µA typ | Digital inputs = $0 V \text{ or } 5.5 V$ | |
| | | 1.0 | µA max | | |

 1 Temperature range for B version is $-40^\circ C$ to $+85^\circ C.$ 2 Guaranteed by design, not subject to production test.

SINGLE SUPPLY

 V_{DD} = 5 V ± 10%, V_{SS} = 0 V, GND = 0 V. All specifications -40°C to +85°C, unless otherwise noted.

Table 3.

| | | 4 | | |
|-------|---|---|--|--|
| +25°C | -40°C to +85°C | Unit | Test Conditions/Comments | |
| | | | | |
| | 0 V to V _{DD} | V | $V_{DD} = 4.5 V, V_{SS} = 0 V$ | |
| 7 | | Ωtyp | $V_s = 0 V$ to 4.5 V, $I_{Ds} = -10 \text{ mA}$; see Figure 1 | |
| 10 | 12.5 | Ωmax | | |
| 0.8 | | Ωtyp | $V_{s} = 0 V$ to 4.5 V, $I_{Ds} = -10 mA$ | |
| 1.1 | 1.3 | Ωmax | | |
| 0.5 | 0.5 | Ωtyp | $V_s = 1.5 V$ to 3.3 V, $I_{Ds} = -10 \text{ mA}$ | |
| | 1.2 | Ωmax | | |
| | | | $V_{DD} = 5.5 V$ | |
| ±0.01 | | nA typ | $V_{s} = 1 V/4.5 V$, $V_{D} = 4.5 V/1 V$; see Figure 16 | |
| | +1 | | | |
| | | | $V_{s} = V_{D} = 1 V/4.5 V$; see Figure 17 | |
| | +1 | | | |
| 10.25 | | платах | | |
| | 24 | Vmin | | |
| | | | | |
| 0.005 | 0.0 | - | | |
| 0.005 | 1 | | $V_{IN} = V_{INL} \text{ or } V_{INH}$ | |
| 2 | ±0.1 | | | |
| 2 | | р⊦ тур | | |
| | | | | |
| | | | | |
| - | | ns typ | $R_L = 300 \Omega, C_L = 35 pF$ | |
| 220 | 280 | ns max | $V_s = 3.3 V$; see Figure 18 | |
| 50 | | ns typ | $R_L = 300 \Omega, C_L = 35 pF$ | |
| 75 | 110 | ns max | Vs = 3.3 V; see Figure 18 | |
| 70 | | ns typ | $R_L = 300 \Omega$, $C_L = 35 pF$ | |
| | 10 | ns min | $V_{S1} = V_{S2} = 3.3 V$; see Figure 19 | |
| | | | | |
| 50 | | ns typ | $R_L = 300 \Omega$, $C_L = 35 pF$ | |
| 85 | 110 | ns max | Vs = 3.3 V; see Figure 18 | |
| 210 | | ns typ | $R_L = 300 \Omega, C_L = 35 pF$ | |
| 340 | 420 | ns max | V _s = 3.3 V; see Figure 18 | |
| 170 | | ns typ | $R_L = 300 \Omega, C_L = 35 pF$ | |
| | 10 | ns min | $V_s = 3.3 V$; see Figure 20 | |
| 6 | | pC typ | $V_s = 0 V$, $R_s = 0 \Omega$, $C_L = 1 nF$; see Figure 21 | |
| | | | $R_L = 50 \Omega$, $C_L = 5 pF$, $f = 1 MHz$; see Figure | |
| | | | 22 | |
| -67 | | dB typ | $R_L = 50 \Omega$, $C_L = 5 pF$, $f = 1 MHz$; see Figure 23 | |
| 190 | | MHz typ | $R_L = 50 \Omega$, $C_L = 5 pF$; see Figure 24 | |
| | | | f = 1 MHz | |
| | | | f = 1 MHz | |
| | | F* -7 P | $V_{DD} = 5.5 V$ | |
| | | | | |
| 0.001 | | μA typ | Digital inputs = 0 V or 5.5 V | |
| _ | $+25^{\circ}C$ 7 10 0.8 1.1 0.5 ± 0.01 ± 0.25 ± 0.01 ± 0.25 ± 0.01 ± 0.25 20 0.005 2 120 220 50 75 70 50 85 210 340 170 6 -67 -67 | $\begin{bmatrix} & & & & & & & & & & & & & & & & & & &$ | +25°C -40°C to +85°C Unit 7 0 V to V _{DD} V 7 12.5 Ω max 0.8 0 V to V _{DD} Ω typ 1.1 1.3 Ω max 0.5 Ω typ Ω max 0.5 Ω typ Ω max ±0.01 ±1 Π max ±0.01 ±1 nA max ±0.01 ±1 nA max ±0.01 ±1 nA max 0.005 ±1 nA max 0.005 ±1 nA max 0.005 ±1 ns typ 120 24 V min 220 280 ns max 50 110 ns typ 70 10 ns typ 10 ns typ ns max 70 10 ns typ 340 420 ns typ 10 ns typ ns typ 340 420 ns typ 70 10 | |

¹ Temperature range for B version is -40°C to +85°C. ² Guaranteed by design, not subject to production test.

ABSOLUTE MAXIMUM RATINGS

 $T_A = 25^{\circ}C$, unless otherwise noted.

Table 4.

| Parameter | Rating |
|---|--|
| V _{DD} to V _{SS} | 13 V |
| V _{DD} to GND | –0.3 V to +6.5 V |
| V _{ss} to GND | +0.3 V to -6.5 V |
| Analog Inputs ¹ | $V_{SS} - 0.3 V$ to $V_{DD} + 0.3 V$ |
| Digital Inputs ¹ | -0.3 V to V _{DD} + 0.3 V or 30 mA (whichever occurs first) |
| Peak Current, S or D | 100 mA (pulsed at 1 ms, 10% duty cycle maximum) |
| Continuous Current, S or D | 50 mA |
| Operating Temperature Range | |
| Industrial (B Version) | -40°C to +85°C |
| Storage Temperature Range | –65°C to +150°C |
| Junction Temperature | 150°C |
| MSOP | |
| θ_{JA} Thermal Impedance | 206°C/W |
| θ_{JC} Thermal Impedance | 44°C/W |
| SOT-23 | |
| θ_{JA} Thermal Impedance | 229.6°C/W |
| θ_{JC} Thermal Impedance | 91.99°C/W |
| Lead Temperature, Soldering (10 sec) | 300°C |
| IR Reflow, Peak Temperature | 220°C |

¹ Overvoltages at IN, S, or D are clamped by internal diodes. Current should be limited to the maximum ratings given.

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Only one absolute maximum rating may be applied at a time.

ESD CAUTION



ESD (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS

| D 1 S1 2 GND 3 V _{DD} 4 | ADG619/ ADG620 TOP VIEW (Not to Scale) | 8 S2 7 V _{SS} 6 IN 5 NC | 12617-002 |
|---|---|---|-----------|
| N | C = NO CONNEC | т | 0261 |
| Figu | ıre 2. 8-Lead S((RJ-8) | OT-23 | |

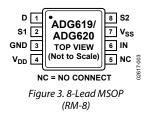


Table 5. Pin Function Descriptions

| Pin No. | Mnemonic | Description |
|---------|-----------------|---|
| 1 | D | Drain Terminal. Can be an input or output. |
| 2 | S1 | Source Terminal. Can be an input or output. |
| 3 | GND | Ground (0 V) Reference. |
| 4 | V _{DD} | Most Positive Power Supply. |
| 5 | NC | No Connect. Not internally connected. |
| 6 | IN | Logic Control Input. |
| 7 | Vss | Most Negative Power Supply. This pin is only used in dual-supply applications and should be tied to ground in single-supply applications. |
| 8 | S2 | Source Terminal. Can be an input or output. |

TYPICAL PERFORMANCE CHARACTERISTICS

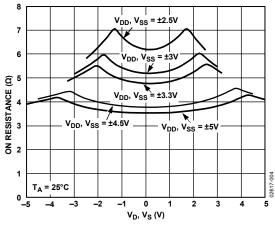


Figure 4. On Resistance vs. V_D, V_s (Dual Supply)

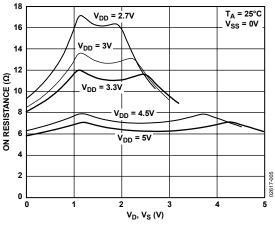


Figure 5. On Resistance vs. V_D, V_s (Single Supply)

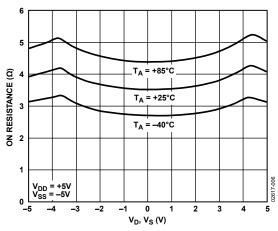


Figure 6. On Resistance vs. V_D, V_S for Different Temperatures (Dual Supply)

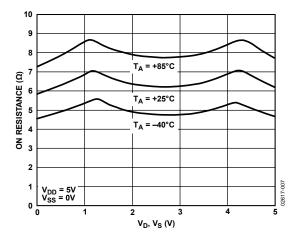


Figure 7. On Resistance vs. V_D, V_S for Different Temperatures (Single Supply)

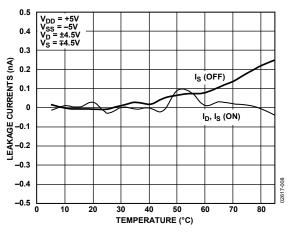


Figure 8. Leakage Currents vs. Temperature (Dual Supply)

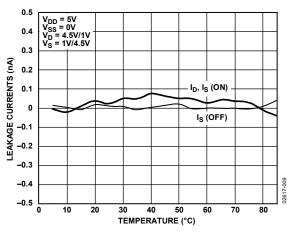


Figure 9. Leakage Currents vs. Temperature (Single Supply)

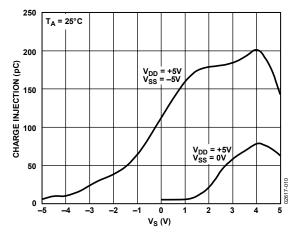
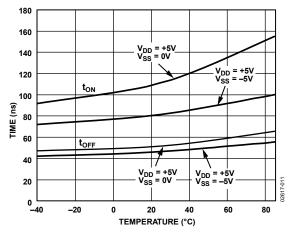
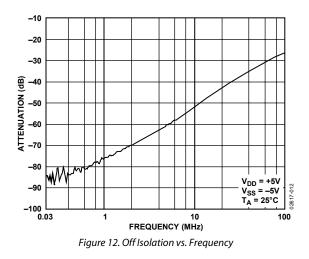
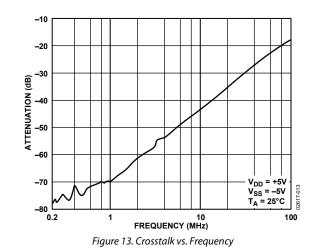


Figure 10. Charge Injection vs. Source Voltage









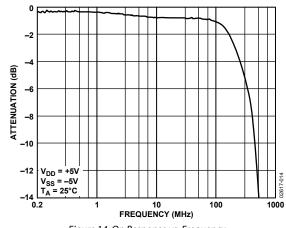


Figure 14. On Response vs. Frequency

TERMINOLOGY

 \mathbf{I}_{DD}

Positive supply current.

Iss Negative supply current.

R_{ON} Ohmic resistance between D and S terminals.

 ΔR_{ON} On resistance match between any two channels.

$R_{\rm FLAT \ (ON)}$

Flatness is defined as the difference between the maximum and minimum value of on resistance as measured over the specified analog signal range.

Is (Off) Source leakage current with the switch off.

I_D, I_s (On) Channel leakage current with the switch on.

 $\mathbf{V}_{D}, \mathbf{V}_{S}$ Analog voltage on Terminal D and Terminal S.

V_{INL} Maximum input voltage for Logic 0.

 \mathbf{V}_{INH} Minimum input voltage for Logic 1.

I_{INL}, I_{INH} Input current of the digital input.

Cs (Off) Off switch source capacitance. C_D, C_s (On) On switch capacitance.

ton

Delay between applying the digital control input and the output switching on.

toff

Delay between applying the digital control input and the output switching off.

 $\mathbf{t}_{\mathrm{MBB}}$

On time is measured between the 80% points of both switches, when switching from one address state to another.

t_{BBM}

Off time or on time is measured between the 90% points of both switches, when switching from one address state to another.

Charge Injection

A measure of the glitch impulse transferred from the digital input to the analog output during switching.

Crosstalk

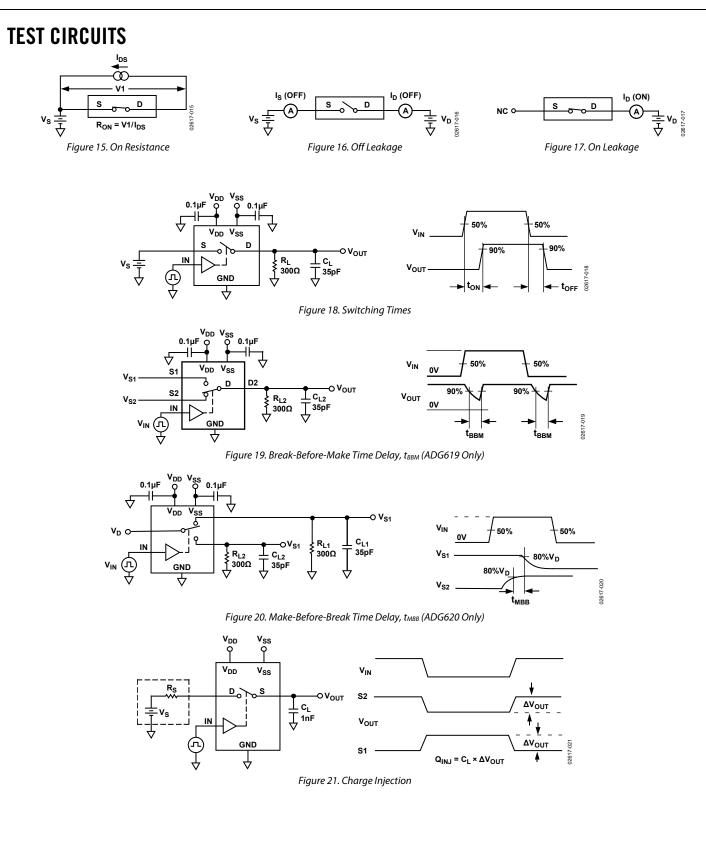
A measure of unwanted signal coupled through from one channel to another as a result of parasitic capacitance.

Off Isolation

A measure of unwanted signal coupling through an off switch.

Bandwidth The frequency response of the on switch.

Insertion Loss The loss due to the on resistance of the switch.



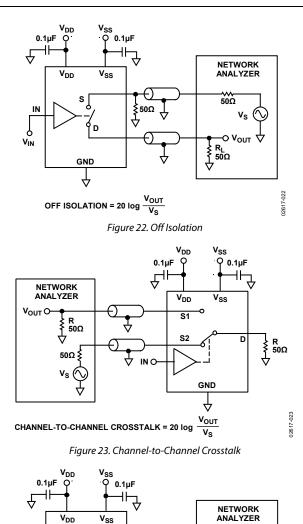


Figure 24. Bandwidth

INSERTION LOSS = 20 log $\frac{V_{OUT}$ WITH SWITCH V_S WITHOUT SWITCH

 \diamond

ϯ

Ε.

-OV_{OUT} φ

vs(V)

02617-024

 V_{SS}

VDD

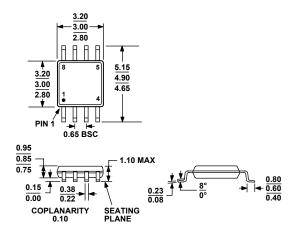
IN

s

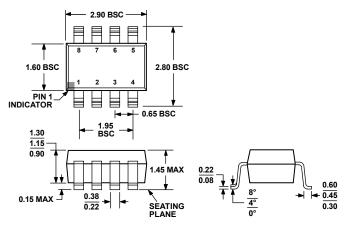
GND Ą

D

OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MO-187-AA Figure 25. 8-Lead Mini Small Outline Package [MSOP] (RM-8) Dimensions shown in millimeters



COMPLIANT TO JEDEC STANDARDS MO-178-BA Figure 26. 8-Lead Small Outline Transistor Package [SOT-23] (RJ-8) Dimensions shown in millimeters

ORDERING GUIDE

| Model | Temperature Range | Package Description | Package Option | Branding ¹ |
|--------------------------------|-------------------|--|----------------|-----------------------|
| ADG619BRM | -40°C to +85°C | 8-Lead Mini Small Outline Package (MSOP) | RM-8 | SVB |
| ADG619BRM-REEL | –40°C to +85°C | 8-Lead Mini Small Outline Package (MSOP) | RM-8 | SVB |
| ADG619BRM-REEL7 | –40°C to +85°C | 8-Lead Mini Small Outline Package (MSOP) | RM-8 | SVB |
| ADG619BRMZ ² | -40°C to +85°C | 8-Lead Mini Small Outline Package (MSOP) | RM-8 | SCC |
| ADG619BRMZ-REEL ² | –40°C to +85°C | 8-Lead Mini Small Outline Package (MSOP) | RM-8 | SCC |
| ADG619BRMZ-REEL7 ² | -40°C to +85°C | 8-Lead Mini Small Outline Package (MSOP) | RM-8 | SCC |
| ADG619BRT-REEL | -40°C to +85°C | 8-Lead Small Outline Transistor Package (SOT-23) | RJ-8 | SVB |
| ADG619BRT-REEL7 | -40°C to +85°C | 8-Lead Small Outline Transistor Package (SOT-23) | RJ-8 | SVB |
| ADG619BRT-500RL7 | -40°C to +85°C | 8-Lead Small Outline Transistor Package (SOT-23) | RJ-8 | SVB |
| ADG619BRTZ-REEL ² | -40°C to +85°C | 8-Lead Small Outline Transistor Package (SOT-23) | RJ-8 | SCC |
| ADG619BRTZ-REEL7 ² | -40°C to +85°C | 8-Lead Small Outline Transistor Package (SOT-23) | RJ-8 | SCC |
| ADG619BRTZ-500RL7 ² | -40°C to +85°C | 8-Lead Small Outline Transistor Package (SOT-23) | RJ-8 | SCC |
| ADG620BRM | -40°C to +85°C | 8-Lead Mini Small Outline Package (MSOP) | RM-8 | SWB |
| ADG620BRM-REEL | -40°C to +85°C | 8-Lead Mini Small Outline Package (MSOP) | RM-8 | SWB |
| ADG620BRM-REEL7 | -40°C to +85°C | 8-Lead Mini Small Outline Package (MSOP) | RM-8 | SWB |
| ADG620BRMZ ² | -40°C to +85°C | 8-Lead Mini Small Outline Package (MSOP) | RM-8 | S21 |
| ADG620BRT-REEL | -40°C to +85°C | 8-Lead Small Outline Transistor Package (SOT-23) | RJ-8 | SWB |
| ADG620BRT-REEL7 | -40°C to +85°C | 8-Lead Small Outline Transistor Package (SOT-23) | RJ-8 | SWB |
| ADG620BRTZ-REEL7 ² | –40°C to +85°C | 8-Lead Small Outline Transistor Package (SOT-23) | RJ-8 | S21 |

 $^{\rm 1}$ Branding on SOT-23 and MSOP is limited to three characters due to space constraints. $^{\rm 2}$ Z = RoHS Compliant Part.

NOTES

NOTES



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